

[Document Name] Specification

[Title of the Invention] LEAD-FREE SOLDER ALLOY

[Technical Field]

[0001]

5 The present invention relates to a lead-free solder alloy having less deterioration over time and excellent long-term reliability, and a solder joint using the solder alloy.

2. Description of Related Art

[0002]

10 In order to reduce the global environmental load, a lead-free solder has been widely distributed as a bonding material of electronic components, and a Sn-Ag-Cu system solder alloy or a Sn-Cu-Ni system solder alloy is a representative composition thereof.

 Recently, in addition to the Sn-Ag-Cu system solder alloy and
15 the Sn-Cu-Ni system solder alloy, a lead-free solder alloy in which Bi, In or Sb, etc. is added and a lead-free solder alloy such as a Sn-Zn solder alloy, in accordance with soldering purpose and soldering characteristics have been proposed.

[0003]

20 In particular, the lead-free solder alloy in which Bi, Sb or In is added for the purpose of increasing mechanical strength of soldered joints or decreasing solidus temperature, is disclosed.

 For example, Patent document 1 discloses a lead-free solder alloy allowing the melting point of solder to be easily controlled by
25 adding 0.01 to 3 wt% of Bi to a basic composition of Sn-Cu-Ni.

In addition, Patent document 2 discloses a lead-free solder alloy having improved mechanical strength by adding Bi to a basic composition of Sn-Cu-Sb in a proportion of 1 wt% or less.

Further, Patent document 3 discloses a lead-free solder alloy
5 having effects of increasing adhesive strength and decreasing the solidus temperature by adding 0.001 to 5 wt% of Cu, Ni and Bi to Sn.

Further, the applicant discloses, in Patent document 4, a lead-free solder alloy exhibiting strong joining strength at the time
10 of soldering by forming an intermetallic compound having a hexagonal close-packed structure at a soldered joint and its joining interface, by adding a prescribed amount of Ni and Cu to a Sn-Bi eutectic composition.

[0004]

15 However, the techniques disclosed in Patent documents 1 to 4, also have problems to be solved. For example, the solder alloy composition disclosed in Patent document 1 requires 2 to 5 wt% of blending amount of Cu, and a soldering temperature exceeding 400°C which is a temperature of at least 150°C higher than that of
20 the Sn-Ag-Cu system solder alloy or Sn-Cu-Ni system solder alloy which is a representative lead-free solder composition.

Further, in the solder alloy composition disclosed in Patent document 2, 10 wt% or more of Sb is blended to the basic composition thereof, such that the solidus temperature is 230°C or
25 higher as described in the example, and as in Patent document 1, it

is necessary to perform a soldering process at a higher temperature, as compared to a conventional representative lead-free solder composition.

Further, the technique disclosed in Patent document 3 is not
5 a solder alloy composition capable of being applied to various solder bonding, but a solder alloy composition limited to super fine wire solder, and thus has problems regarding versatility.

Meanwhile, the technique disclosed in Patent document 4 is a technique for the purpose of providing strong joining by forming
10 an intermetallic compound having a NiAs-type crystal structure in a joining interface, in which a blending ratio of Sn and Bi is Sn : Bi = 76 to 37 atomic wt% : 23 to 63 atomic wt%, and the technique is directed to a composition in the vicinity of eutectic.

Furthermore, Publication Patent document 5 discloses a
15 technique relating to a solder alloy composition which is adapted to prevent an occurrence of tin pest at an extremely low temperature, and includes Sn-Cu-Ni-Bi having good wettability and impact resistance. For the purpose of the corresponding invention, the composition has numerical values limited to a range that a blending
20 amount of Cu is 0.5 to 0.8 mass%, a blending amount of Ni is 0.02 to 0.04 mass%, and a blending amount of Bi is 0.1 mass% or more and less than 1 mass%.

[0005]

In general, when an electronic device is being used, a
25 soldered joint of the electronic device is in a conducting state, and in

some cases, the solder bonding part may be exposed to high temperature.

Herein, in terms of reliability of the solder bonding, a bonding strength when the solder bonding part is exposed to high temperature becomes very important, as well as the bonding strength at the time of the soldering.

Meanwhile, the techniques disclosed in Patent documents 1 to 5 do not teach any content concerning the bonding strength when the soldered joint is exposed to high temperature for a long time.

Further, a lead-free solder alloy enabling soldering with high reliability which is enough to withstand long-term use of the electronic device, and having versatility with respect to the solder bonding is required.

[Related Art Document]

[Patent Document]

[0006]

[Patent Document 1] Japanese Patent Laid-open Publication No. 2001-334384

[Patent Document 2] Japanese Patent Laid-open Publication No. 2004-298931

[Patent Document 3] Japanese Patent Laid-open Publication No. 2006-255762

[Patent Document 4] Japanese Patent Laid-open Publication No. 2013-744

[Patent Document 5] Publication WO 2009/131114

[Summary of the Invention]

[Problems to be Solved by the Invention]

[0007]

An object of the present invention is to provide a lead-free
5 solder alloy and a soldered joint capable of maintaining strong
joining strength without reducing the bonding strength even in a
high-temperature state after soldering, and having high reliability
and versatility.

[Means for Solving the Problems]

10 [0008]

The present inventors focused on a lead-free solder alloy
composition and an intermetallic compound, and have repeatedly
conducted intensive study for the above-described object. As a
result, they have found that, by adding a specific amount of Bi to a
15 lead-free solder alloy having Sn-Cu-Ni as a basic composition, a
decrease in the bonding strength is suppressed even when a solder
bonding part is exposed to high temperature, and thereby the
present invention has been completed on the basis of the above
finding.

20 [0009]

That is, the present invention provides a lead-free solder
alloy composition having Sn-Cu-Ni as a basic composition, including
76.0 to 99.5 mass% of Sn, 0.1 to 2.0 mass% of Cu, and 0.01 to 0.5
mass% of Ni, and further including 0.1 to 5.0 mass% of Bi, thereby
25 enabling soldering with high reliability which maintains joining

strength without decreasing the bonding strength of a soldered joint even when it is exposed to high temperature for a long time, as well as at the time of bonding.

[Advantageous Effects]

5 [0010]

The lead-free solder alloy according to the present invention has versatility which is not limited by a method of using a solder product or a shape thereof, and even when the soldered joint is exposed to a high-temperature state for a long time, the joining
10 strength will not decrease. Therefore, the lead-free solder alloy can be widely applied to a device having a solder bonding part in which high current flows, a device which is exposed to a high-temperature state, or the like, as well as the joining of an electronic device.

[Brief Description of the Drawings]

15 [0011]

FIG. 1 is a graph illustrating an experimental result.

FIG. 2 is a graph summarizing measurement results of tensile strength of each sample having a composition of Table 2.

FIG. 3 is a graph summarizing measurement results of
20 tensile strength of each sample having a composition of Table 4.

FIG. 4 is a graph summarizing measurement results of tensile strength of samples having different additional amounts of Cu.

FIG. 5 is a graph summarizing measurement results of
25 tensile strength of samples having different additional amounts of

Ni.

FIG. 6 is a graph summarizing measurement results of tensile strength of samples having different additional amounts of Ge.

5 FIG. 7 is a graph summarizing measurement results of tensile strength of samples having different additional amounts of In.

FIG. 8 is a graph summarizing measurement results of elongation rate of In-changed samples.

10 FIG. 9 is a graph summarizing measurement results of tensile strength of samples in which an additional element is added.

[Modes for Carrying out the Invention]

[0012]

Hereinafter, the present invention will be described in detail.

15 Conventionally, the joining strength at the time of soldering has been an important item for soldering of electronic devices, or the like, and the solder alloy capable of improving the joining strength at the time of soldering has been developed and provided.

 However, soldered joints used in electronic devices or the like
20 can be frequently exposed to high temperature or in a state in which current flows, especially during using the electronic device, and in some cases, an increase in temperature of the soldered joints may be accelerated by the external environment. Therefore, in order to improve the reliability of the soldered joints, it is required to
25 suppress deterioration over time of the soldered joints which is

exposed to a high-temperature state.

Meanwhile, as a method for evaluating the soldered joints, a method of using a test referred to as a thermal cycling test wherein a soldered joint is repeatedly left in a high-temperature state and a low-temperature state for a prescribed time is generally used. However, it is also known that in the method, since the soldered joints is left in a high-temperature state and then left in a low-temperature state for a prescribed time, a condition of the soldered joints after the test is different from that of an aging test in which the soldered joints is left only in a high-temperature state for a long time.

The present invention relates to a solder alloy composition capable of suppressing a decrease in joining strength of a soldered joint due to continuously exposing the soldered joints in a high-temperature state, that is, an environment which is an example of a situation according to actual state of using electronic devices.

[0013]

In particular, the present invention relates to a lead-free solder alloy which may include 76.0 to 99.5 mass% of Sn, 0.1 to 2.0 mass% of Cu, 0.01 to 0.5 mass% of Ni, and 0.1 to 5.0 mass% of Bi, and a soldered joint using the lead-free solder alloy.

[0014]

Further, it is also possible to add one or two or more elements selected from 0.1 to 5.0 mass% of Sb, 0.1 to 10.0 mass% of In, 0.001 to 1.0 mass% of Ge, and 0.001 to 1.0 mass% of Ga to a

basic composition including 76.0 to 99.5 mass% of Sn, 0.1 to 2.0 mass% of Cu, 0.01 to 0.5 mass% of Ni, and 0.1 to 5.0 mass% of Bi.

In addition, an element such as P, Co, Al, Ti, Ag, etc, may also be arbitrarily added to the lead-free solder alloy having Sn-Cu-Ni-Bi as the basic composition thereof of the present invention, in a range in which the effects of the present invention are obtained.
[0015]

A synergy effect of increasing mechanical strength of the soldered joints is expected while achieving the effects of the present invention by adding Sb to the solder alloy having the Sn-Cu-Ni-Bi as the basic composition thereof.

Further, when adding In, even if Cu or Sb is blended to the solder alloy in an amount of exceeding 1 mass%, an effect of decreasing solidus temperature may be obtained, while achieving the effects of the present invention, and an effect of decreasing a load applied to electronic components joined to electronic devices, soldering work, or the like may be expected.

Further, when adding Ge or Ga, it is possible to suppress oxidation of the soldered joint and improve wettability, and a synergy effect of improving long-term reliability and soldering characteristics of the soldered joint may also be expected, while achieving the effects of the present invention.

[0016]

Next, effects of the present invention will be described by illustrating an experimental example.

An aging test to be described below was performed on the lead-free solder alloy of the present invention and its properties was evaluated.

[Aging Test]

5 (Method)

1) A solder alloy having a composition shown in Table 1 was prepared and melted, and then cast into a dog bone-shaped mold having a cross section of 10 mm x 10 mm, thereby preparing a sample for measurement.

10 2) The measurement sample was left at 150°C for 500 hours to perform aging processing.

3) The samples on which the aging processing was performed and the samples on which the aging processing was not performed are pulled until they are cut using a testing machine, AG-IS
15 (manufactured by Shimadzu Corp.) under a condition of 10 mm/min at room temperature (20°C to 25°C), thereby measuring tensile strength of the samples.

(Result)

Measured results are illustrated in FIG. 1.

20 [0017]

TABLE 1

Sample No.	Compositions (wt%)	Element (wt%)							
		Sn	Cu	Ni	Bi	Ge	Ag	In	Mn
1	Sn-0.7Cu-0.05Ni-Ge	Balance	0.7	0.05	—	0.007	—	—	—
2	Sn-0.7Cu-0.05Ni-0.5Bi-Ge	Balance	0.7	0.05	0.5	0.007	—	—	—
3	Sn-0.7Cu-0.05Ni-1.0Bi-Ge	Balance	0.7	0.05	1.0	0.006	—	—	—
4	Sn-0.7Cu-0.05Ni-1.5Bi-Ge	Balance	0.7	0.05	1.5	0.006	—	—	—
5	Sn-0.7Cu-0.05Ni-2.0Bi-Ge	Balance	0.7	0.05	2.0	0.006	—	—	—
6	Sn-0.7Cu-0.3Ag	Balance	0.7	—	—	—	0.3	—	—
7	Sn-0.7Cu-0.8Ag	Balance	0.7	—	—	—	0.8	—	—
8	Sn-1.0Cu-0.5Ag-0.05Mn	Balance	1.0	—	—	—	0.5	—	0.008
9	Sn-0.5Cu-3.0Ag	Balance	0.5	—	—	—	3.0	—	—

[0018]

The graph illustrated in FIG. 1 illustrates the measurement results of the samples in which the aging processing was not performed on the left side, and the measurement results of the samples in which the aging processing was performed on the right side, respectively.

The samples of the present invention correspond to No. 2 to 5, and it can be appreciated that the tensile strength of the sample in which the aging processing was performed is not much decreased as compared to that of the sample in which the aging processing was not performed.

Whereas, sample No. 1 and samples No. 6 to 9 which are comparative samples show a remarkable decrease in tensile strength of the sample in which the aging processing was performed as compared to the sample in which the aging processing was not performed.

From the results, it could be clearly appreciated that even though the lead-free solder alloy having Sn-Cu-Ni-Bi as the basic composition of the present invention was exposed to high

temperature of 150°C for 500 hours, the decrease in the tensile strength thereof was suppressed as compared to other lead-free solder alloy compositions.

[0019]

5 Hereinafter, with regard to the basic composition of Sn-Cu-Ni-Bi, a change in tensile strength resulting from a change in an additional amount of Bi will be described in detail. In more detail, it will be described based on the measurement result of a change in tensile strength of samples in which 0 mass% to 6 mass% of Bi are
10 added to such composition.

Table 2 is a composition table showing compositions of the samples used in the measurement of the tensile strength.

As a Comparative Example (Sample i: Sample name is SN2), a composition of Sn-Cu-Ni to which Bi is not blended is contained.
15 Further, the samples including Bi are referred to as Sample ii “Sample name: +0.1Bi*,” Sample iii “Sample name: +0.5Bi*,” Sample iv “Sample name: +1.0Bi*,” Sample v “Sample name: +1.5Bi*,” Sample vi “Sample name: +2.0Bi*,” Sample vii “Sample name: +3.0Bi*,” Sample viii “Sample name: +4.0Bi*,” Sample ix
20 “Sample name: +5.0Bi*,” and Sample x “Sample name: +6.0Bi*.” In Samples i to x, Bi is included in an amount of 0.1 mass%, 0.5 mass%, 1.0 mass%, 1.5 mass%, 2.0 mass%, 3.0 mass%, 4.0 mass%, 5.0 mass%, and 6.0 mass%, respectively.

[0020]

25 Samples i to x having the compositions in Table 2 were

prepared by the above described method in paragraph [0016].

Subsequently, the aging processing was performed on the samples at 150°C for 0 hours and 500 hours, and the tensile strength thereof was measured.

5 [0021]

TABLE 2

No	SAMPLE NAME	Element (wt%)			
		Sn	Cu	Ni	Bi
SAMPLE i	SN2	Balance	0.7	0.05	0
SAMPLE ii	+0.1Bi*	Balance	0.7	0.05	0.1
SAMPLE iii	+0.5Bi*	Balance	0.7	0.05	0.5
SAMPLE iv	+1.0Bi*	Balance	0.7	0.05	1.0
SAMPLE v	+1.5Bi*	Balance	0.7	0.05	1.5
SAMPLE vi	+2.0Bi*	Balance	0.7	0.05	2.0
SAMPLE vii	+3.0Bi*	Balance	0.7	0.05	3.0
SAMPLE viii	+4.0Bi*	Balance	0.7	0.05	4.0
SAMPLE ix	+5.0Bi*	Balance	0.7	0.05	5.0
SAMPLE x	+6.0Bi*	Balance	0.7	0.05	6.0

[0022]

TABLE 3

A (0 HOURS)	SAMPLE No.	i	ii	iii	iv	v	vi	vii	viii	ix	x
	SAMPLE NAME	SN2	+0.1Bi *	+0.5Bi *	+1.0Bi *	+1.5Bi *	+2.0Bi *	+3.0Bi *	+4.0Bi *	+5.0Bi *	+6.0Bi *
	MEASUREMENT RESULT (Mpa)	32.0	33.0	40.0	47.0	51.5	58.9	68.0	78.1	81.5	87.0

C (500 HOURS)	SAMPLE No.	i	ii	iii	iv	v	vi	vii	viii	ix	x
	SAMPLE NAME	SN2	+0.1Bi *	+0.5Bi *	+1.0Bi *	+1.5Bi *	+2.0Bi *	+3.0Bi *	+4.0Bi *	+5.0Bi *	+6.0Bi *
	MEASUREMENT RESULT (Mpa)	27.2	30.2	36.7	46.2	52.6	60.0	69.1	74.9	71.8	62.5

STRENGTH CHANGE RATE (C/A)	(%)	85.0%	91.5%	91.8%	98.3%	102.1%	101.9%	101.6%	95.9%	88.1%	71.8%
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[0023]

Table 3 is a table showing measurement results of Samples i to x. "A" of Table 3 is a measurement result of the tensile strength after the aging for 0 hours, and "C" of Table 3 is a measurement result of the tensile strength after the aging for 500 hours, and the strength change rate is a result obtained by measuring a change in the tensile strength after the aging for 500 hours while considering "A" (0 hours) as 100%. Further, FIG. 2 is a graph summarizing the measurement results of the tensile strength of Samples i to x.

[0024]

With respect to the aging processing time of 0 hours and 500 hours, it can be appreciated that Samples ii to x in which Bi is added have higher tensile strength than that of Sample i in which Bi is not added.

Further, in the case of the aging processing for 500 hours, Samples ii to x in which an additional amount of Bi is 0.1 mass% or

more show higher tensile strength than Sample i in which Bi is not added. In addition, Samples iv to vii in which an additional amount of Bi is 1.0 mass% to 3.0 mass% show a strength change rate of 98% or higher. It is appreciated that change rate of the
5 tensile strength after the aging for 500 hours is significantly low and particularly, the tensile strength after the aging for 500 hours of samples v to vii are more improved than the case in which the aging processing is not performed.

Meanwhile, Sample x in which an additional amount of Bi is
10 6 mass% shows a change rate of the tensile strength of 71.8% which is lower than 85.2% of Sample i in which Bi is not added, thus it can be said that 6 mass% is not a preferable blending amount.

[0025]

Further, with respect to a case of adding Ge to the basic
15 composition of Sn-Cu-Ni-Bi, a change in the tensile strength resulting from a change in an additional amount of Bi will be described in detail. More specifically, a change in the tensile strength of the samples in which Bi is added to such composition in an amount of 0 to 6 mass% was measured.

20 [0026]

Table 4 is a composition table showing compositions of the samples used in the measurement of the tensile strength. As illustrated in FIG. 3, Bi is not included in Sample 1 "SAC305" and Sample 2 "SN1." And in Sample 3 "+0.1Bi," Sample 4 "+0.5Bi,"
25 Sample 5 "+1.0Bi," Sample 6 "+1.5Bi," Sample 7 "+2.0Bi," Sample 8

+3.0Bi,” Sample 9 “+4.0Bi,” Sample 10 “+5.0Bi,” and Sample 11 “+6.0Bi,” Bi is included in an amount of 0.1 mass%, 0.5 mass%, 1 mass%, 1.5 mass%, 2 mass%, 3 mass%, 4 mass%, 5 mass%, and 6 mass%, respectively.

5 [0027]

Further, in all the samples except for Sample 1 “SAC305,” 0.7 mass% of Cu, 0.05 mass% of Ni, and 0.006 mass% of Ge are included, and the remainder is Sn. In addition, in Sample 1 “SAC305,” 3 mass% of Ag and 0.5 mass% of Cu are included, and
10 the remainder is Sn.

[0028]

Hereinafter, for convenience of explanation, Sample 1 “SAC305,” Sample 2 “SN1,” Sample 3 “+10.1Bi,” Sample 4 “+0.5Bi,” Sample 5 “+1.0Bi,” Sample 6 “+1.5Bi,” Sample 7 “+2.0Bi,” Sample 8
15 “+3.0Bi,” Sample 9 “+4.0Bi,” Sample 10 “+5.0Bi,” and Sample 11 “+6.0Bi” will be referred to as “Sample 1,” “Sample 2,” “Sample 3,” “Sample 4,” “Sample 5,” “Sample 6,” “Sample 7,” “Sample 8,” “Sample 9,” “Sample 10,” and “Sample 11,” respectively.

[0029]

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TABLE 4

No	SAMPLE NAME	Element(wt%)					
		Sn	Ag	Cu	Ni	Ge	Bi
SAMPLE 1	SNC305	Balance	3	0.5	0	0	0
SAMPLE 2	SN1	Balance	0	0.7	0.05	0.006	0
SAMPLE 3	+0.1Bi	Balance	0	0.7	0.05	0.006	0.1
SAMPLE 4	+0.5Bi	Balance	0	0.7	0.05	0.006	0.5
SAMPLE 5	+1.0Bi	Balance	0	0.7	0.05	0.006	1
SAMPLE 6	+1.5Bi	Balance	0	0.7	0.05	0.006	1.5
SAMPLE 7	+2.0Bi	Balance	0	0.7	0.05	0.006	2
SAMPLE 8	+3.0Bi	Balance	0	0.7	0.05	0.006	3
SAMPLE 9	+4.0Bi	Balance	0	0.7	0.05	0.006	4
SAMPLE 10	+5.0Bi	Balance	0	0.7	0.05	0.006	5
SAMPLE 11	+6.0Bi	Balance	0	0.7	0.05	0.006	6

[0030]

Samples 1 to 11 having compositions as shown in Table 4 were prepared by the above described method. The aging

5 processing was performed on the prepared Samples 1 to 11 for 0 hours and 500 hours at 150°C, and the tensile strength was measured by the above described method.

[0031]

TABLE 5

A (0 HOURS)	SAMPLE No.	1	2	3	4	5	6	7	8	9	10	11
	SAMPLE NAME	SNC305	SN1	+0.1Bi	+0.5Bi	+1.0Bi	+1.5Bi	+2.0Bi	+3.0Bi	+4.0Bi	+5.0Bi	+6.0Bi
	MEASUREMENT RESULT (Mpa)	48.2	32.5	32.8	39.9	46.5	51.6	58.7	68.2	78.3	81.6	86.1

C (500 HOURS)	SAMPLE No.	1	2	3	4	5	6	7	8	9	10	11
	SAMPLE NAME	SNC305	SN1	+0.1Bi	+0.5Bi	+1.0Bi	+1.5Bi	+2.0Bi	+3.0Bi	+4.0Bi	+5.0Bi	+6.0Bi
	MEASUREMENT RESULT (Mpa)	35.6	27.7	30	36.5	45.6	52.7	59.1	70.2	75.1	71.9	61.8

STRENGTH CHANGE RATE (C/A)	(%)	73.9%	85.2%	91.5%	91.6%	98.2%	102.2%	100.7%	102.9%	95.9%	88.1%	71.8%
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[0032]

Table 5 is a table showing measurement results of Samples 1 to 11. "A" of Table 5 is a measurement result of the tensile strength after the aging for 0 hours, and "C" of Table 5 is a measurement result of tensile strength after the aging for 500 hours, and the strength change rate is a result showing a change in the tensile strength after the aging for 500 hours in percentage (%). Further, FIG. 3 is a graph summarizing the measurement results of the tensile strength of Samples 1 to 11.

[0033]

With respect to the aging processing time of 0 hours and 500 hours, it can be appreciated that Samples 3 to 11 in which Bi is added have higher tensile strength than that of Sample 2 in which Bi is not added.

Further, in the case of the aging processing for 500 hours, Samples 4 to 11 in which an additional amount of Bi is 0.5 mass%

or more show higher tensile strength than that of Sample 1 in which Bi is not added and Ag is added. In addition, it can be appreciated that Samples 5 to 8 in which an additional amount of Bi is 1.0 mass% to 3.0 mass% show a strength change rate of 98% or higher, which is a significantly low change rate of the tensile strength after the aging for 500 hours.

Accordingly, in the case of Samples 4 to 11, since Ag is not used, it is possible to achieve cost decrease while having the effect of improving the tensile strength.

10 [0034]

Further, it can be appreciated that in the case of Samples 3 to 9, that is, as an additional amount of Bi is increased from 0.1 mass% to 4 mass%, the tensile strength was increased. In addition, in such a range of the additional amount of Bi, there is no large difference between the tensile strength of the case in which the aging processing was not performed and the tensile strength of the case in which the aging processing was performed for 500 hours.

15 [0035]

Meanwhile, in the case of Samples 10 and 11 in which an additional amount of Bi is 5 mass% or more, as the additional amount of Bi increased, the tensile strength of the case in which the aging processing was not performed is increased, but the strength change rate tended to be decreased, in particular, in the case of 6 mass%, a change rate of the tensile strength is 71.8% which is lower than 85.2% of the case in which Bi is not added (Sample 2), and

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thus it may be said that 6 mass% is not a preferable blending amount.

[0036]

As may be appreciated from the above measurement results,
5 when the lead-free solder alloy consisting of Sn, Cu, Ni, Bi, and Ge is exposed to a harsh usage environment, that is, high temperature of 150°C for a long time, it is preferable that an additional amount of Bi is 0.5 to 4.0 mass%, and more preferably, 1.0 to 3.0 mass%. In such a range of the additional amount of Bi, as described above,
10 even when the aging processing is performed for 500 hours, high tensile strength may be obtained. Further, there is no large difference between the tensile strength of the case in which the aging processing is not performed and the tensile strength of the case in which the aging processing is performed for 500 hours, that
15 is, a stable tensile strength can be obtained.

[0037]

Furthermore, in the case of Sample 10 in which an additional amount of Bi is 5 mass%, the tensile strength after the aging processing was lower than the tensile strength of the case in which
20 the aging processing was not performed, as described above. However, since the tensile strength of Samples 1 and 2 in which Bi is not added are lower than that of Sample 10 after the aging process was performed, the additional amount of Bi may be 0.1 to 5.0 mass%.

25 [0038]

Further, hereinafter, with regard to a case of adding Ge to the basic composition of Sn-Cu-Ni-Bi, a change in the tensile strength resulting from a change in an additional amount of Cu will be described in detail.

5 [0039]

In this case, Ni, Bi, and Ge are included in an amount of 0.05 mass%, 1.5 mass%, and 0.006 mass%, respectively. Further, Cu is added in an amount of 0.05 to 2.2 mass%, and the remainder is Sn. Hereinafter, for convenience of explanation, a sample in which 0.05
10 mass% of Cu is added, a sample in which 0.1 mass% of Cu is added, a sample in which 0.7 mass% of Cu is added, a sample in which 2 mass% of Cu is added, and a sample in which 2.2 mass% of Cu is added will be referred to as “0.05Cu,” “0.1Cu,” “0.7Cu,” “2Cu,” and “2.2Cu,” respectively.

15 [0040]

The samples were prepared by the above described method and the aging processing was performed on the prepared samples at 150°C for 0 hours and 500 hours, and the tensile strength thereof was measured by the above described method.

20 [0041]

TABLE 6

A (0 HOURS)	SAMPLE NAME	0.05Cu	0.1Cu	0.7Cu	2Cu	2.2Cu
	MEASUREMENT RESULT (Mpa)	46.4	46.6	51.6	61.2	60.2

C (500 HOURS)	SAMPLE NAME	0.05Cu	0.1Cu	0.7Cu	2Cu	2.2Cu
	MEASUREMENT RESULT (Mpa)	44.7	45.4	52.7	60.9	57.6

STRENGTH CHANGE RATE (C/A)	(%)	96%	97%	102%	100%	96%
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[0042]

Table 6 is a table showing measurement results of the tensile strength of the samples having different additional amounts of Cu as described above. “A” of Table 6 is a measurement result of the tensile strength after the aging for 0 hours, and “C” of Table 4 is a measurement result of the tensile strength after the aging for 500 hours. Further, FIG. 4 is a graph summarizing the measurement results of the tensile strength of the samples having different additional amounts of Cu.

[0043]

All of “0.05Cu” to “2.2Cu” have a desirable strength change rate higher than 90% before and after the aging. However, since problems such as an increase in so-called Cu leaching may occur, it is not preferable that an additional amount of Cu is 0.05 mass%. Meanwhile, since problems such as a rise in liquid phase temperature, an occurrence of shrinkage cavity, or the like may

occur, it is not preferable that an additional amount of Cu is 2.2 mass%.

[0044]

From the above description, when Ge is added to the basic composition of Sn-Cu-Ni-Bi, in the above described composition, it is preferable that an additional amount of Cu is 0.1 to 2.0 mass%.

[0045]

Further, hereinafter, with regard to the case in which Ge is added to the basic composition of Sn-Cu-Ni-Bi, a change in the tensile strength resulting from a change in an additional amount of Ni will be described in detail.

[0046]

In this case, Cu, Bi, and Ge are included in an amount of 0.7 mass%, 1.5 mass%, and 0.006 mass%, respectively, further, Ni is added in an amount of 0.005 to 0.55 mass%, and the remainder is Sn. Hereinafter, for convenience of explanation, a sample in which 0.005 mass% of Ni is added, a sample in which 0.01 mass% of Ni is added, a sample in which 0.05 mass% of Ni is added, a sample in which 0.5 mass% of Ni is added, and a sample in which 0.55 mass% of Ni is added will be referred to as "0.005Ni," "0.01Ni," "0.05Ni," "0.5Ni," and "0.55Ni," respectively.

[0047]

The samples were prepared by the above described method and the aging processing was performed on the prepared samples at 150°C for 0 hours and 500 hours, and the tensile strength thereof

was measured by the above described method.

[0048]

TABLE 7

A (0 HOURS)	SAMPLE NAME	0.005Ni	0.01Ni	0.05Ni	0.5Ni	0.55Ni
	MEASUREMENT RESULT (Mpa)	52.7	51.5	51.6	55.5	56.1

C (500 HOURS)	SAMPLE NAME	0.005Ni	0.01Ni	0.05Ni	0.5Ni	0.55Ni
	MEASUREMENT RESULT (Mpa)	50.7	50.7	52.7	56.5	55.1

STRENGTH CHANGE RATE (C/A)	(%)	96%	98%	102%	102%	98%
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5 [0049]

Table 7 is a table showing measurement results of the tensile strength of the samples having different additional amounts of Ni as described above. "A" of Table 7 is a measurement result of the tensile strength after the aging for 0 hours, and "C" of Table 7 is a measurement result of the tensile strength after the aging for 500 hours. Further, FIG. 5 is a graph summarizing the measurement results of the tensile strength of the samples having different additional amounts of Ni.

[0050]

15 All of "0.005Ni" to "0.55Ni" have a desirable strength change rate higher than 90% before and after the aging. However, it is not

preferable that the additional amount of Ni is small since an effect of suppressing coarsening of an intermetallic compound at an interface of alloy layers may be lost so as to cause cracks.

Meanwhile, it is not preferable that an additional amount of Ni
5 exceeds 0.5 mass%, since the liquid phase temperature may rise to cause an occurrence of shrinkage cavity.

[0051]

From the above description, when Ge is added to the basic composition of Sn-Cu-Ni-Bi, in the above described composition, it is
10 preferable that an additional amount of Ni is 0.01 to 0.5 mass%.

[0052]

Further, hereinafter, with regard to the case in which Ge is added to the basic composition of Sn-Cu-Ni-Bi, a change in the tensile strength resulting from a change in an additional amount of
15 Ge will be described in detail.

[0053]

In this case, Cu, Ni, and Bi are included in an amount of 0.7 mass%, 0.05 mass%, and 1.5 mass%, respectively. Further, Ge is added in an amount of 0.0001 to 1 mass%, and the remainder is Sn.
20 Hereinafter, for convenience of explanation, a sample in which 0.0001 mass% of Ge is added, a sample in which 0.001 mass% of Ge is added, a sample in which 0.006 mass% of Ge is added, a sample in which 0.1 mass% of Ge is added, and a sample in which 1 mass% of Ge is added will be referred to as "0.0001Ge," "0.001Ge,"
25 "0.006Ge," "0.1Ge," and "1Ge," respectively.

[0054]

The samples were prepared by the above described method and the aging processing was performed on the prepared samples at 150°C for 0 hours and 500 hours, and the tensile strength thereof
 5 was measured by the above described method.

[0055]

TABLE 8

A (0 HOURS)	SAMPLE NAME	0.0001Ge	0.001Ge	0.006Ge	0.1Ge	1 Ge
	MEASUREMENT RESULT (Mpa)	52.4	52.7	51.6	59.0	79.4

C (500 HOURS)	SAMPLE NAME	0.0001Ge	0.001Ge	0.006Ge	0.1Ge	1 Ge
	MEASUREMENT RESULT (Mpa)	50.7	51.5	52.7	52.9	55.3

STRENGTH CHANGE RATE (C/A)	(%)	97%	98%	102%	90%	70%
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[0056]

10 Table 8 is a table showing measurement results of the tensile strength of the samples having different additional amounts of Ge as described above. “A” of Table 8 is a measurement result of the tensile strength after the aging for 0 hours, and “C” of Table 8 is a measurement result of the tensile strength after the aging for 500
 15 hours. Further, FIG. 6 is a graph summarizing the measurement results of the tensile strength of the samples having different additional amounts of Ge.

[0057]

All of "0.0001Ge" to "0.1Ge" have a desirable strength change rate higher than 90% before and after the aging. However, it is not preferable that an additional amount of Ge is 0.0001 mass%, since
5 an effect of preventing oxidation may be suppressed. Meanwhile, when an additional amount of Ge is 1 mass%, the strength change rate before and after the aging is much lower than 90%.

[0058]

From the above description, when Ge is added to the basic
10 composition of Sn-Cu-Ni-Bi, in the above described composition, it is preferable that an additional amount of Ge is 0.001 to 0.1 mass%.

[0059]

Meanwhile, since it is expected that the effect of preventing oxidation is improved as the additional amount of Ge is increased,
15 an additional amount of Ge may also be 0.001 to 1.0 mass%.

[0060]

Further, hereinafter, with regard to the case in which In is added to the basic composition of Sn-Cu-Ni-Bi, a change in the tensile strength resulting from a change in an additional amount of
20 In will be described in detail.

[0061]

In this case, Cu, Ni, Bi and Ge are included in an amount of 0.7 mass%, 0.05 mass%, 1.5 mass%, and 0.006 mass%, respectively. Further, In is added in an amount of 0 to 10 mass%, and the
25 remainder is Sn. Hereinafter, for convenience of explanation, a

sample in which 0 mass% of In is added, a sample in which 0.1 mass% of In is added, a sample in which 3 mass% of In is added, a sample in which 4 mass% of In is added, a sample in which 5 mass% of In is added, a sample in which 6 mass% of In is added, a sample in which 7 mass% of In is added, and a sample in which 10 mass% of In is added will be referred to as "0In," "0.1In," "3In," "4In," "5In," "6In," "7In," and "10In," respectively.

[0062]

The samples were prepared by the above described method and the aging processing was performed on the prepared samples at 150°C for 0 hours and 500 hours, and the tensile strength thereof was measured by the above described method.

[0063]

TABLE 9

A (0 HOURS)	SAMPLE NAME	0In	0.1In	3In	4In	5In	6In	7In	10In
	MEASUREMENT RESULT (Mpa)	51.6	51.4	56.7	57.9	62.0	66.1	67.5	67.3

C (500 HOURS)	SAMPLE NAME	0In	0.1In	3In	4In	5In	6In	7In	10In
	MEASUREMENT RESULT (Mpa)	52.7	51.4	58.7	60.4	67	73.5	74.4	48.8

STRENGTH CHANGE RATE (C/A)	(%)	102%	100%	104%	104%	108%	111%	110%	73%
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[0064]

Table 9 is a table showing measurement results of the tensile strength of the samples having different additional amounts of In (hereinafter, simply referred to as In-changed sample) as described above. “A” of Table 9 is a measurement result of the tensile strength after the aging for 0 hours, and “C” of Table 9 is a measurement result of the tensile strength after the aging for 500 hours. Further, FIG. 7 is a graph summarizing the measurement results of the tensile strength of the samples having different additional amounts of In.

10 [0065]

All of the In-changed samples except for “10In” have a desirable strength change rate higher than 90% before and after the aging. Accordingly, it may also be considered that it is effective that the additional amount of In is 0.1 to 7 mass%.

15 [0066]

Meanwhile, Table 10 is a table showing measurement results of elongation rate of the In-changed samples. “A” of Table 10 is a measurement result of elongation rate after the aging for 0 hours, and “C” of Table 10 is a measurement result of elongation rate after the aging for 500 hours, and the elongation change rate is a result showing a change in elongation rate after the aging for 500 hours, in percentage (%). Further, FIG. 8 is a graph summarizing the measurement results of the elongation rate of the above-described In-changed samples.

25 [0067]

TABLE 10

A (0 HOURS)	SAMPLE NAME	0In	0.1In	3In	4In	5In	6In	7In	10In
	MEASUREMENT RESULT (Mpa)	33	39	38	32	27	22	22	14

C (500 HOURS)	SAMPLE NAME	0In	0.1In	3In	4In	5In	6In	7In	10In
	MEASUREMENT RESULT (%)	37	37	35	35	32	26	21	24

STRENGTH CHANGE RATE (C/A)	(%)	112%	95%	92%	109%	119%	118%	95%	171%
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[0068]

Herein, the elongation rate may be obtained by the following
 5 equation. In the equation, “ δ ” represents elongation rate, “ L_0 ”
 represents a length between gauge points before the tensile
 strength measurement, “ L ” is a length between the gauge points
 after the tensile strength measurement.

$$\delta(\%) = (L - L_0) / L_0 \times 100$$

10 [0069]

Further, the elongation rate was calculated using the above
 equation by marking a prescribed length (50 mm, L_0) between the
 gauge points on a test specimen before the tensile strength
 measurement, and measuring a length (L) between the gauge points
 15 at the time of matching fractured pieces of the test specimen after
 the tensile strength measurement.

[0070]

As can be seen from Table 10 and FIG. 8, in a range in which the additional amount of In is 4 mass% (4In) to 6 mass% (6In), all of the samples have a stable elongation change rate higher than 100%. That is, in such a range, the elongation rate is improved after the aging.

[0071]

In other words, in such a range, the transformation may more easily occur after the aging than before the aging. When an impact is applied from the outside, the impact is to be absorbed through the transformation and the strength increases to some degree overall. Therefore, such an improvement of the elongation rate may contribute to the improvement of the strength.

[0072]

However, when the additional amount of In is excessively large, a temperature at which the transformation starts may be decreased.

[0073]

From the above description, when In is added to the basic composition of Sn-Cu-Ni-Bi, in the above described composition, it is preferable that an additional amount of In is 0.1 to 6 mass%.

[0074]

Meanwhile, since it is expected that as the additional amount of In is increased, the liquid phase temperature is decreased and the strength is increased, and therefore the additional amount of In may also be 0.1 to 10 mass%.

[0075]

Hereinafter, a strength change of the "SAC305" sample including only Ag, Cu, and Sn without Ni, Ge, and Bi being added thereto, and samples with the basic composition of Sn-Cu-Ni-Bi in which Ge, Sb, In, Ga, P, Co, Al, Ti, or Ag (hereinafter, referred to as an additional element) is added, will be described below.

[0076]

TABLE 11

A (0 HOURS)	SAMPLE No.		I	II	III	IV	V	VI
	SAMPLE NAME	SAC305	+1.5Bi	0.001Ge	0.1Ge	0.1Sb	5Sb	0.1In
	MEASUREMENT RESULT (Mpa)	48.2	51.6	52.7	59.0	52.6	64.6	51.4
C (500 HOURS)	SAMPLE NAME	SAC305	+1.5Bi	0.001Ge	0.1Ge	0.1Sb	5Sb	0.1In
	MEASUREMENT RESULT (Mpa)	35.6	52.7	51.5	52.9	52.2	64.4	51.4
STRENGTH CHANGE RATE (C/A)	(%)	74%	102%	98%	90%	99%	100%	100%

VII	VIII	IX	X	X I	X II	X III
10In	0.001Ga	1Ga	0.005P	0.05Co	0.01Al	0.005Ti
67.3	50.6	62.5	50.7	50.4	49.9	52.4

10In	0.001Ga	1Ga	0.005P	0.05Co	0.01Al	0.005Ti
48.8	51.6	71.8	53.3	54.0	51.8	54.2
73%	102%	115%	105%	107%	104%	103%

[0077]

Table 11 is a table showing measurement results of the tensile strength of the samples in which the additional element is added. “A” of Table 11 is a measurement result of the tensile strength after the aging for 0 hours, and “C” of Table 11 is a measurement result of the tensile strength after the aging for 500 hours. Further, FIG. 9 is a graph summarizing the measurement results of the tensile strength of the samples in which the additional element is added.

10 [0078]

Further, a composition of the samples in which the additional element is added is shown in Table 12. Here, since “SAC305” has the same composition as that of “SAC305” (produced by Nihon Superior Co., Ltd.) in Table 4 above, and the composition of “+1.5Bi” (I) has been already shown in Table 2, the compositions thereof will not be represented in detail.

[0079]

TABLE 12

	Ge	Sb	In	Ga	P	Co	Al	Ti	Ag
0.001Ge(II)	0.001	0	0	0	0	0	0	0	0
0.1Ge(III)	0.1	0	0	0	0	0	0	0	0
0.1Sb(IV)	0.006	0.1	0	0	0	0	0	0	0
5Sb(V)	0.006	5	0	0	0	0	0	0	0
0.1In(VI)	0.006	0	0.1	0	0	0	0	0	0
10In(VII)	0.006	0	10	0	0	0	0	0	0
0.001Ga(VIII)	0.006	0	0	0.001	0	0	0	0	0
1Ga(IX)	0.006	0	0	1	0	0	0	0	0
0.005P(X)	0.006	0	0	0	0.005	0	0	0	0
0.05Co(X I)	0.006	0	0	0	0	0.05	0	0	0
0.01Al(X II)	0.006	0	0	0	0	0	0.01	0	0
0.005Ti(X III)	0.006	0	0	0	0	0	0	0.005	0
1Ag(X IV)	0.006	0	0	0	0	0	0	0	1

Unit: Mass%

In all of Samples II to XIV shown in Tables 11 and 12, Cu, Ni and Bi are included in an amount of 0.7 mass%, 0.05 mass%, and 1.5 mass%, respectively. Hereinafter, for convenience of explanation, the content of Cu, Ni, and Bi as described above will be referred to as a basic composition.

[0080]

Further, in Samples II and III, Ge is further included in an amount of 0.001 mass% or 0.1 mass%, respectively, in addition to the above-described basic composition, and the remainder is Sn. In addition, Samples IV to XIV contain 0.006 mass% of Ge together with the above-described basic composition, and further contain the additional elements.

[0081]

As can be seen from FIG. 9 and Table 11, only “SAC305” and “10In” (VII) have a strength change rate lower than 90% before and after the aging. That is, it is determined that, except for Sample
5 VII, the additional element and the corresponding additional amount to each sample maintain the effects of the present invention, that is the effect of improving reliability after the aging (improving tensile strength), while bringing unique effects due to the additional elements.

10 [0082]

For example, Ge and P have a unique effect of preventing oxidation of Sn and solder ingredients due to oxide films. Ti and Ga have unique effects of self-oxidation and increasing bulk strength. In has unique effects of decreasing liquid phase
15 temperature and increasing strength, and Ag has a unique effect of increasing the strength before the aging by dispersion and precipitation strengthening. Co has a unique effect of thinning an intermetallic compound layer, and Al has unique effects of refining the intermetallic compound, suppressing a decrease in the strength
20 after the aging, and self-oxidation.

[0083]

Table 13 is a table showing comparisons between the tensile strength of “SAC305” and the tensile strength of Samples I to XIV before and after the aging. More specifically, Table 13 shows ratios
25 of the tensile strength of Samples I to XIV to the tensile strength of

“SAC305,” and ratios of the tensile strength of “SAC305” and Samples II to XIV to the tensile strength of Sample I, in percentage (%). In other words, Table 13 shows relative tensile strength with respect to “SAC305” and Sample I before and after the aging.

5 [0084]

TABLE 13

Alloy	BEFORE AGING		BEFORE AGING	
	COMPARISON WITH SAC305	COMPARISON WITH SN1+1.5Bi	COMPARISON WITH SAC305	COMPARISON WITH SN1+1.5Bi
SAC305	100	93	100	67
1.5Bi	107	100	148	100
0.001Ge	109	102	145	98
0.1Ge	123	115	149	100
0.1Sb	109	102	147	99
5Sb	134	125	181	122
0.1In	107	100	144	97
10In	140	131	137	93
0.001Ga	105	98	145	98
1Ga	130	121	202	136
0.005P	105	98	150	101
0.05Co	105	98	152	102
0.01Al	104	97	146	98
0.005Ti	109	102	152	103
1Ag	124	116	157	106

Unit: Mass%

[0085]

As can be seen from Table 13, all of Samples II to XIV have a relative tensile strength of 93% or more in both of before and after

the aging, in particular, Samples V and IX have a relative tensile strength exceeding 120% in both of before and after the aging.

From the results as described above, it is also determined that in the case of adding the above-described additional elements, the

5 effects of the present invention may be maintained, and the unique effects of the additional elements may also be obtained, as described above.

[0086]

If it is within the range in which the effects of the present
10 invention are obtained, a shape or a usage of the lead-free solder alloy of the present invention which has Sn-Cu-Ni-Bi as the basic composition is not limited, and the lead-free solder alloy may be used for flow soldering or reflow soldering. The lead-free solder alloy may have a shape such as a solder paste type, a resin flux
15 cored solder type, a powder type, a preform type, and a ball type according to its use, as well as a bar type for flow soldering.

Further, the present invention is also directed to the soldered joint which is soldered with the lead-free solder alloy of the present invention being processed to have various shapes.

20 [Industrial Applicability]

[0087]

The present invention is a lead-free solder alloy having versatility so as not to be limited by a form of a solder product, and as the decrease of joining strength of the soldered joint is little even
25 in a state of being exposed to high temperature for a long time, the

excellent long-term reliability of the soldered joint is maintained.
Accordingly, the present invention may be widely applied to
apparatuses and devices having soldered joints in which high
current flows, apparatuses and devices exposed to a high-
5 temperature state, or the like, as well as soldering of electronic
devices.

WHAT IS CLAIMED IS:

[Claim 1]

A lead-free solder alloy, comprising:

76.0 to 99.5 mass% of Sn;

0.1 to 2.0 mass% of Cu;

0.01 to 0.5 mass% of Ni;

0.1 to 5.0 mass% of Bi; and

unavoidable impurities.

[Claim 2]

The lead-free solder alloy according to claim 1, wherein one or two or more selected from 0.1 to 5.0 mass% of Sb, 0.1 to 10.0 mass% of In, 0.001 to 1.0 mass% of Ge, and 0.001 to 1.0 mass% of Ga are added.

[Claim 3]

The lead-free solder alloy according to claim 1 or 2, wherein Bi is included in an amount of 0.5 to 4 mass%.

[Claim 4]

The lead-free solder alloy according to any one of claims 1 to 3, wherein Bi is included in an amount of 1 to 3 mass%.

[Claim 5]

The lead-free solder alloy according to any one of claims 1 to 4, wherein Ge is included in an amount of 0.001 to 0.1 mass%.

[Claim 6]

The lead-free solder alloy according to any one of claims 1 to

5, wherein In is included in an amount of 0.1 to 6 mass%.

[Claim 7]

The lead-free solder alloy according to any one of claims 1 to 6, further comprising: at least one of P, Co, Ti, Al, and Ag.

[Claim 8]

A soldered joint using the lead-free solder alloy according to any one of claims 1 to 7.